

(Use several sheets if necessary)

BU9-99-152 (12769)

Unassigned

Edward W. Conrad, et al.

Herewith

Unassigned

[illegible][illegible]

		(1978), "E-Beam Line Width And Pattern Location Measurement Tool", IBM Technical Disclosure Bulletin, Vol. 21, No. 1, pp. 151.
		E. Coombs, et al., (1991), "Two-Dimensional Atomic Force Microprobe Trench Metrology System", J. Vac. Sci. Technol., Vol. B9, No. 6, pp. 3612-3616.

Ben ~~Lee~~ Lee

CONSIDERED
12/23/2002

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